

### Features

- Advanced trench technology
- Low on-resistance
- Reliable and Rugged
- Green device available

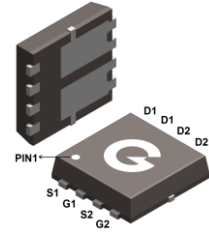
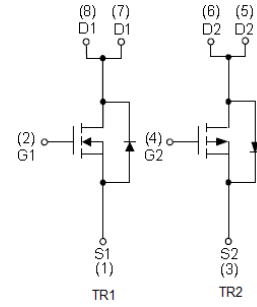
### Applications

- Synchronous Rectification
- Motor Control
- Portable equipment application

### Mechanical Data

- Case: PDFN3x3-8LC
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208

HF



PDFN3×3-8LC

### Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
GBLH3303-3DL8	PDFN3x3-8LC	5000 pcs / Tape & Reel	GBLH3303

### Maximum Ratings (@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	N Channel	P Channel	Unit
Drain-to-Source Voltage	$V_{DSS}$	30	-30	V
Gate-to-Source Voltage	$V_{GSS}$	$\pm 20$	$\pm 20$	V
Continuous Drain Current ( $T_C = 25^\circ\text{C}$ )	$I_D$	20	-17	A
Continuous Drain Current ( $T_A = 25^\circ\text{C}$ ) <sup>*1</sup>		6.5	-5.4	A
Continuous Drain Current ( $T_A = 100^\circ\text{C}$ ) <sup>*1</sup>		4	-3.4	A
Pulsed Drain Current ( $t_p = 10\mu\text{s}$ , $T_A = 25^\circ\text{C}$ )	$I_{DM}$	60	-50	A
Single Pulse Avalanche Energy <sup>*3</sup>	$E_{AS}$	16	30	mJ
Power Dissipation ( $T_C = 25^\circ\text{C}$ )	$P_D$	16		W
Power Dissipation ( $T_A = 25^\circ\text{C}$ ) <sup>*1</sup>		1.5		W
Operating Junction Temperature Range	$T_J$	-55 ~ +150		$^\circ\text{C}$
Storage Temperature Range	$T_{STG}$	-55 ~ +150		$^\circ\text{C}$

### Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	-	-	8	$^\circ\text{C/W}$
Thermal Resistance Junction-to-Air <sup>*1</sup>	$R_{\theta JA}$	-	-	83	$^\circ\text{C/W}$

### Electrical Characteristics-N (@ T<sub>A</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
V <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	30	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V	-	-	1	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V	-	-	±100	nA
<b>On Characteristics</b>						
R <sub>DS(ON)</sub>	Drain-Source On-resistance *2	V <sub>GS</sub> = 10V, I <sub>D</sub> = 6.5A	-	18	20	mΩ
		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 6A	-	24	30	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	1	1.5	2.5	V
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 0V, f = 1MHz	-	5.9	-	Ω
<b>Dynamic Characteristics</b>						
C <sub>ISS</sub>	Input Capacitance	V <sub>GS</sub> = 0V V <sub>DS</sub> = 15V f = 1.0MHz	-	481	-	pF
C <sub>OSS</sub>	Output Capacitance		-	70	-	
C <sub>RSS</sub>	Reverse Transfer Capacitance		-	61	-	
<b>Switching Characteristics</b>						
t <sub>d(ON)</sub>	Turn-on Delay Time *4	V <sub>GS</sub> = 10V V <sub>DD</sub> = 15V I <sub>D</sub> = 10A R <sub>G</sub> = 3Ω	-	1.6	-	ns
t <sub>r</sub>	Turn-on Rise Time *4		-	25.6	-	
t <sub>d(OFF)</sub>	Turn-Off Delay Time *4		-	16.6	-	
t <sub>f</sub>	Turn-Off Fall Time *4		-	9	-	
Q <sub>G</sub>	Total Gate-Charge	V <sub>DD</sub> = 15V V <sub>GS</sub> = 10V I <sub>D</sub> = 10A	-	10.3	-	nC
Q <sub>GS</sub>	Gate to Source Charge		-	1.3	-	
Q <sub>GD</sub>	Gate to Drain (Miller) Charge		-	3.2	-	
<b>Source-Drain Diode Characteristics</b>						
V <sub>SD</sub>	Diode Forward Voltage *2	I <sub>SD</sub> = 20A, V <sub>GS</sub> = 0V	-	1.0	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> = 10A, V <sub>GS</sub> = 0V di/dt = 100A/μs	-	92	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge		-	52	-	nC

### Electrical Characteristics-P (@ T<sub>J</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
V <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA	-30	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -30V, V <sub>GS</sub> = 0V	-	-	-1	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V	-	-	±100	nA
<b>On Characteristics</b>						
R <sub>DS(ON)</sub>	Drain-Source On-resistance *2	V <sub>GS</sub> = -10V, I <sub>D</sub> = -5.7A	-	28	34	mΩ
		V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -4.4A	-	39	50	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA	-1	-1.5	-2.5	V
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 0V, f = 1MHz	-	8	-	Ω
<b>Dynamic Characteristics</b>						
C <sub>ISS</sub>	Input Capacitance	V <sub>GS</sub> = 0V V <sub>DS</sub> = -15V f = 1.0MHz	-	916	-	pF
C <sub>OSS</sub>	Output Capacitance					
C <sub>RSS</sub>	Reverse Transfer Capacitance					
<b>Switching Characteristics</b>						
t <sub>d(ON)</sub>	Turn-on Delay Time *4	V <sub>GS</sub> = -10V V <sub>DD</sub> = -15V I <sub>D</sub> = -7A R <sub>G</sub> = 2.5Ω	-	11	-	ns
t <sub>r</sub>	Turn-on Rise Time *4					
t <sub>d(OFF)</sub>	Turn-Off Delay Time *4					
t <sub>f</sub>	Turn-Off Fall Time *4					
Q <sub>G</sub>	Total Gate-Charge	V <sub>GS</sub> = -10V V <sub>DD</sub> = -15V I <sub>D</sub> = -4A	-	20	-	nC
Q <sub>GS</sub>	Gate to Source Charge					
Q <sub>GD</sub>	Gate to Drain (Miller) Charge					
<b>Source-Drain Diode Characteristics</b>						
V <sub>SD</sub>	Diode Forward Voltage *2	I <sub>SD</sub> = -20A, V <sub>GS</sub> = 0V	-	-1.1	-1.4	V

Notes:

- The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper
- The data tested by pulsed, pulse width ≤ 300μs, duty cycle ≤ 2%
- The E<sub>AS</sub> data shows Max. rating. N: The test condition is V<sub>DD</sub> = 20V, V<sub>GS</sub> = 10V, L = 0.5mH  
P: The test condition is V<sub>DD</sub> = -20V, V<sub>GS</sub> = -10V, L = 0.5mH
- Guaranteed by design, not subject to production

Ratings and Characteristics Curves-N (@  $T_A = 25^\circ\text{C}$  unless otherwise specified)

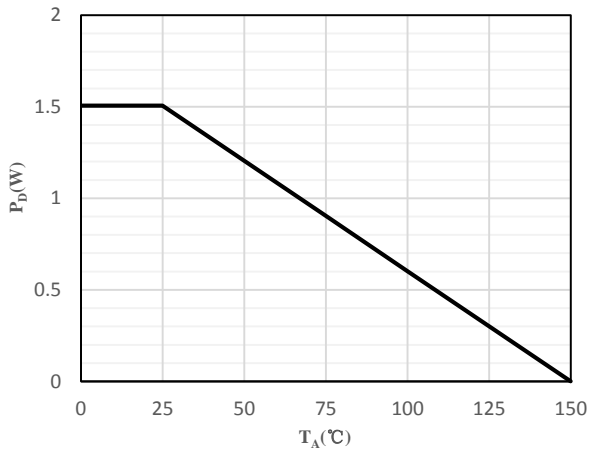


Fig 1 Power Dissipation

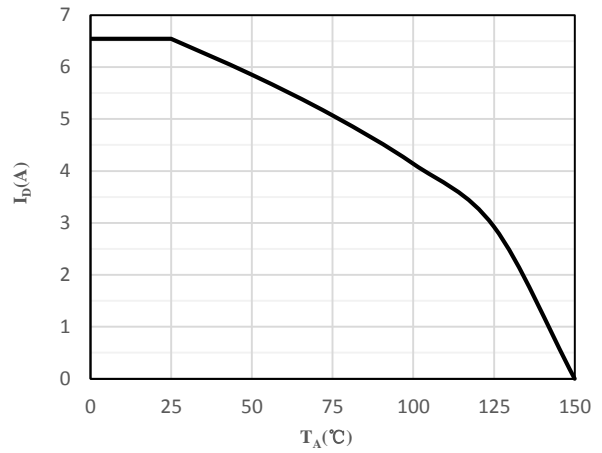


Fig 2 Drain Current

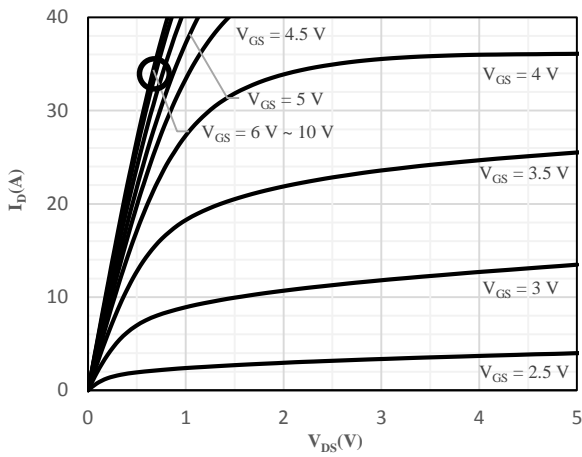


Fig 3 Typical Output Characteristics

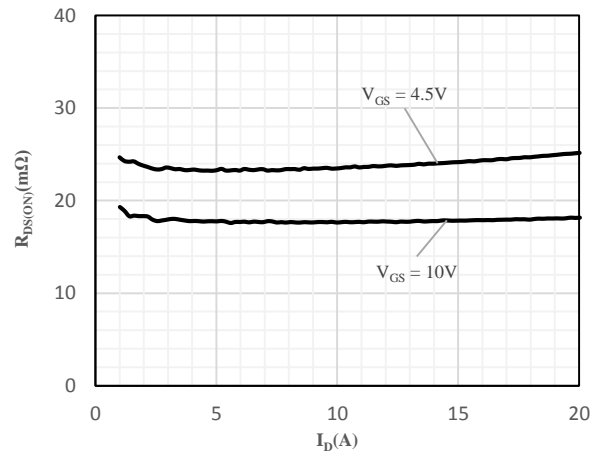


Fig 4 On-Resistance vs. Drain Current and Gate Voltage

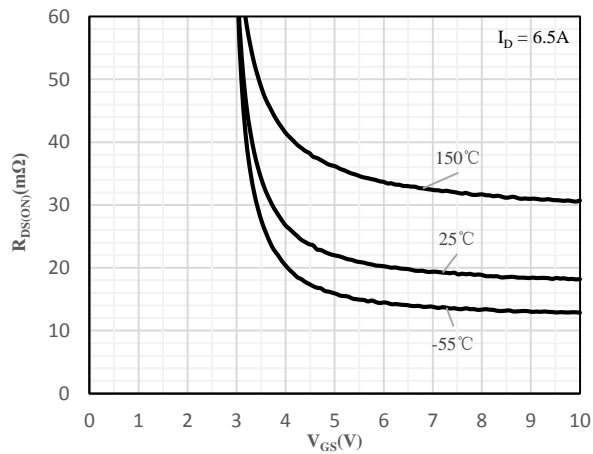


Fig 5 On-Resistance vs. Gate-Source Voltage

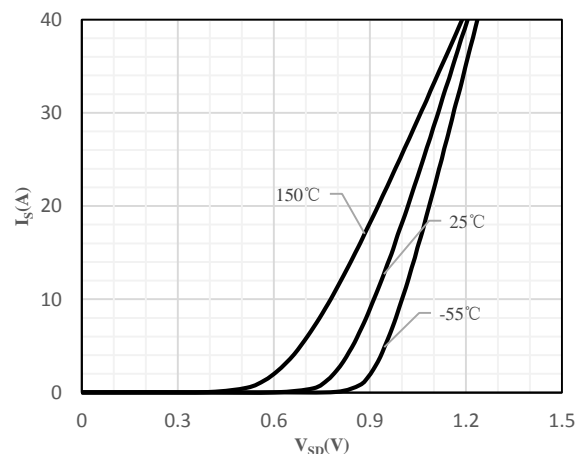


Fig 6 Body-Diode Characteristics

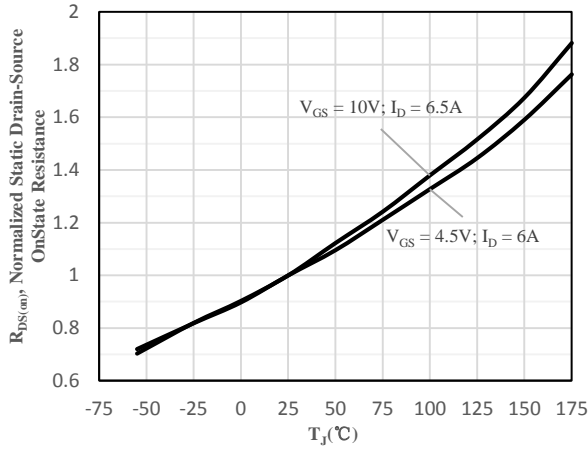


Fig 7 Normalized On-Resistance vs. Junction Temperature

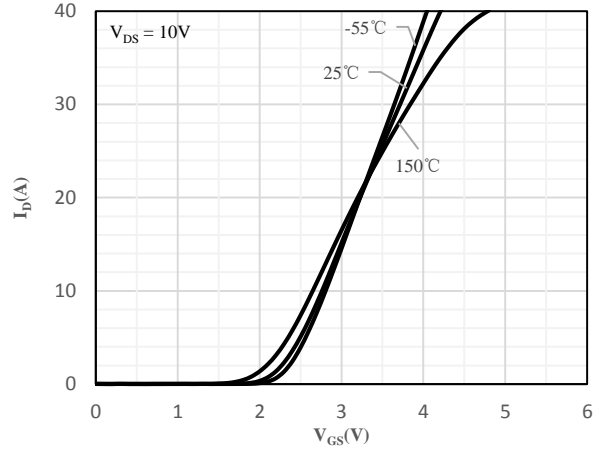


Fig 8 Transfer Characteristics

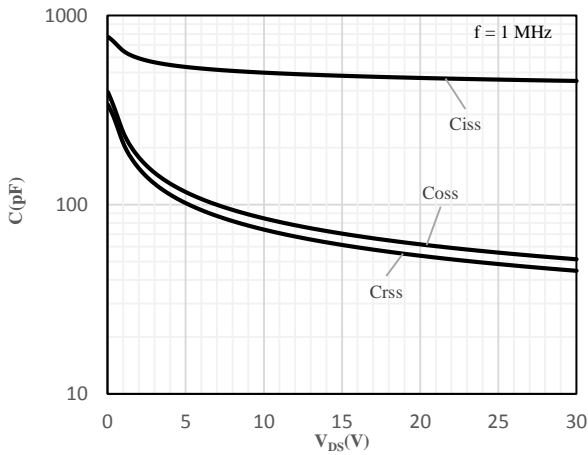


Fig 9 Capacitance Characteristics

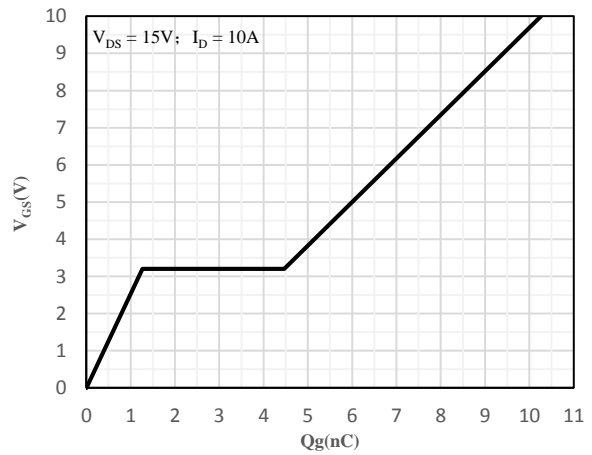


Fig 10 Gate-Charge Characteristics

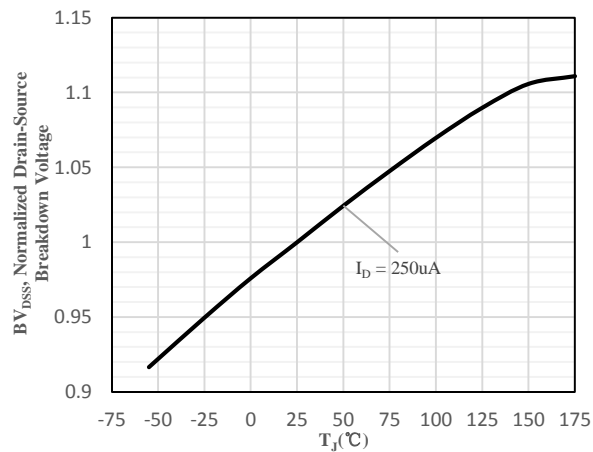


Fig 11 Normalized Breakdown Voltage vs. Junction Temperature

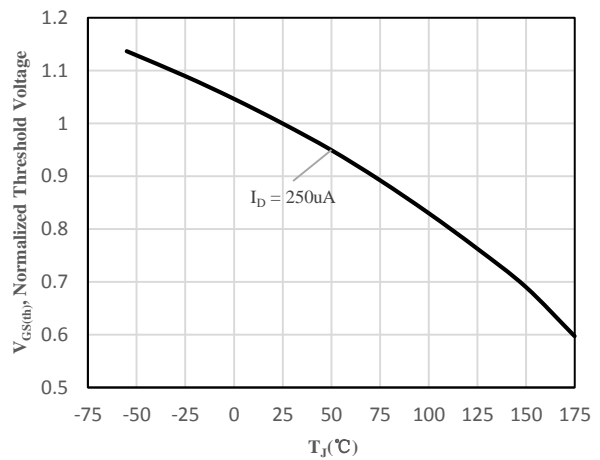
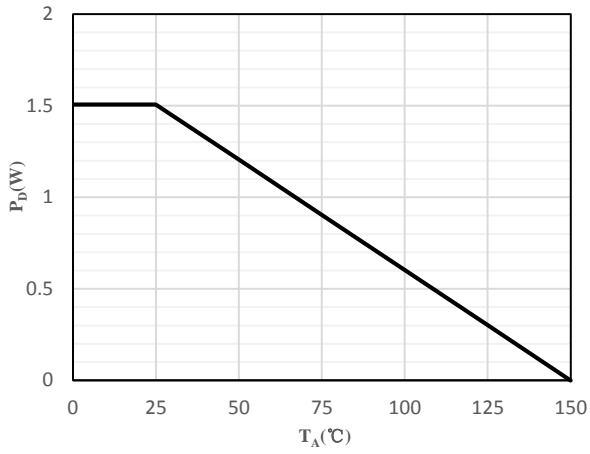
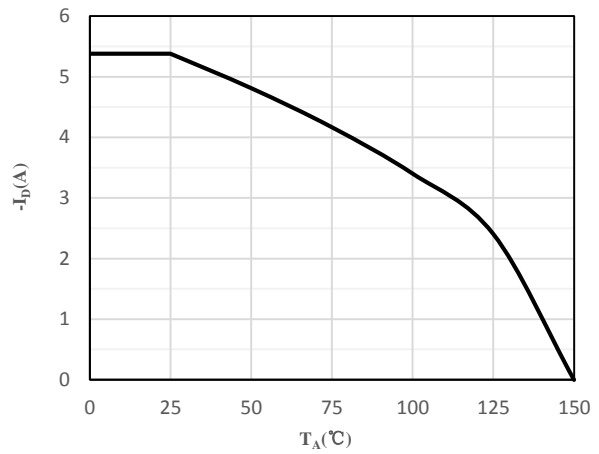


Fig 12 Normalized  $V_{GS(th)}$  vs. Junction Temperature

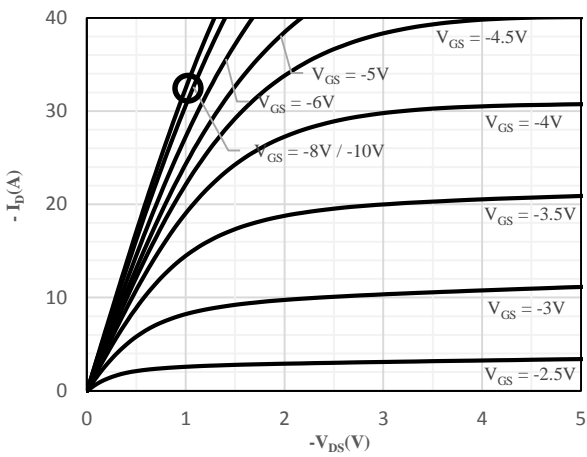
**Ratings and Characteristics Curves-P** (@  $T_A = 25^\circ\text{C}$  unless otherwise specified)



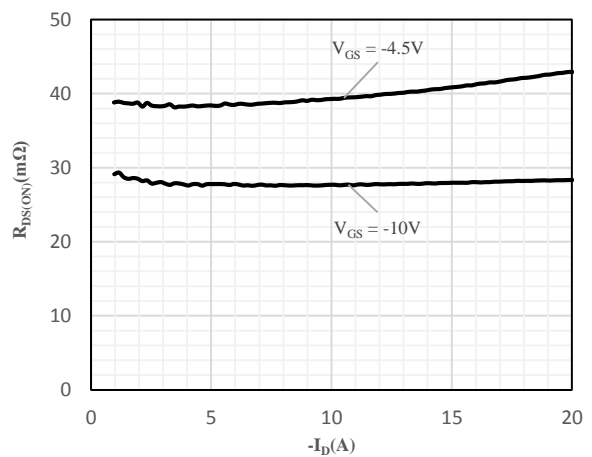
**Fig 1 Power Dissipation**



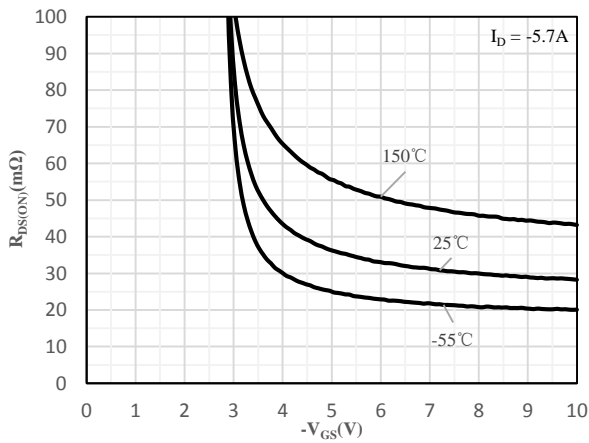
**Fig 2 Drain Current**



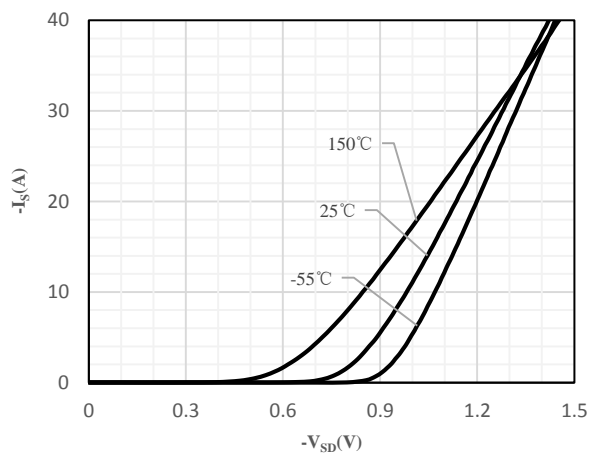
**Fig 3 Typical Output Characteristics**



**Fig 4 On-Resistance vs. Drain Current and Gate Voltage**



**Fig 5 On-Resistance vs. Gate-Source Voltage**



**Fig 6 Body-Diode Characteristics**

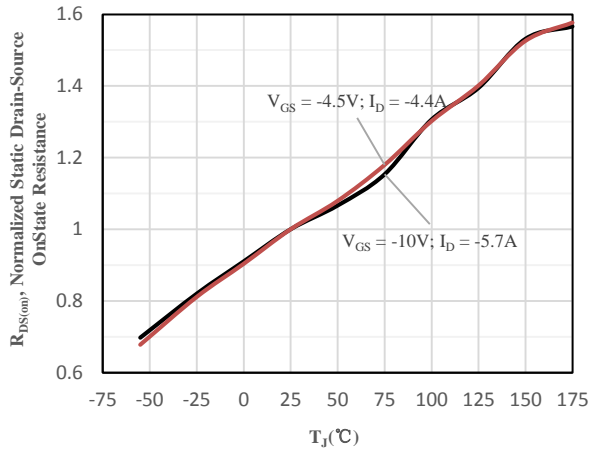


Fig 7 Normalized On-Resistance vs. Junction Temperature

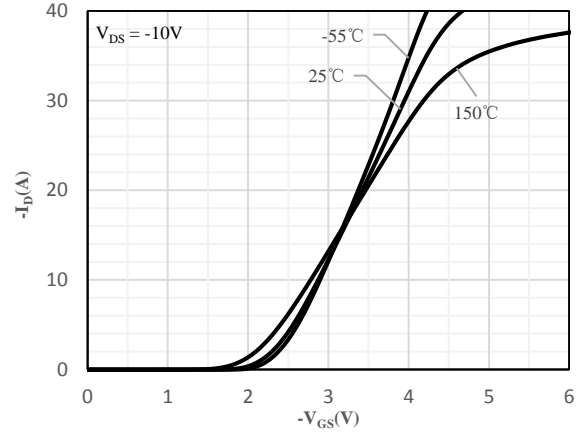


Fig 8 Transfer Characteristics

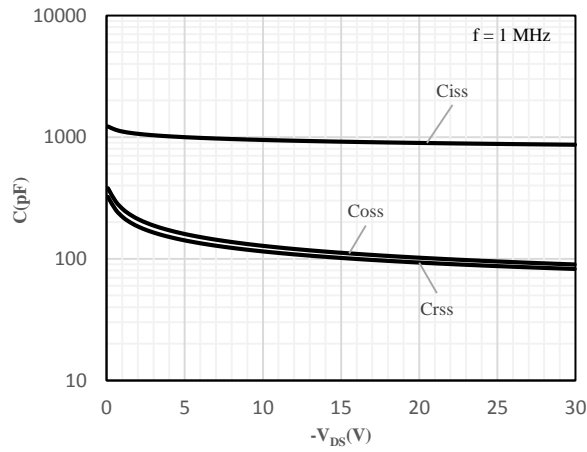


Fig 9 Capacitance Characteristics

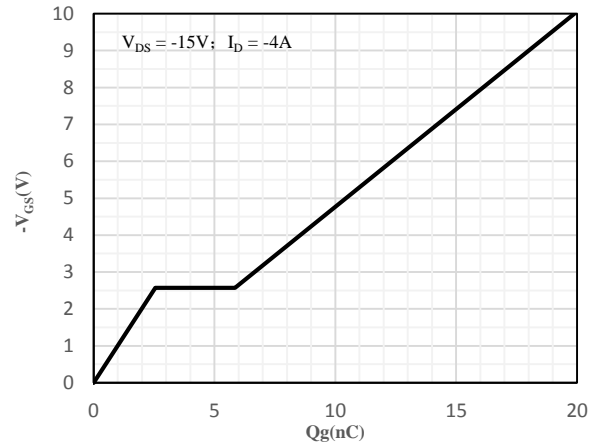


Fig 10 Gate-Charge Characteristics

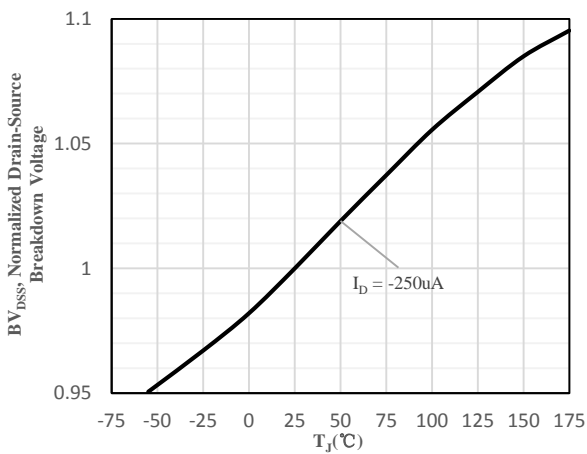


Fig 11 Normalized Breakdown Voltage vs. Junction Temperature

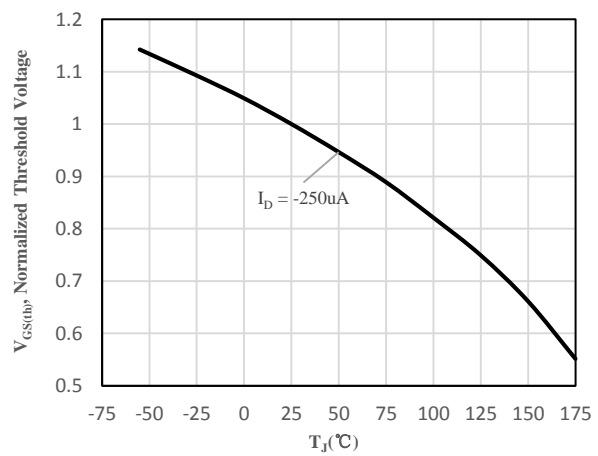
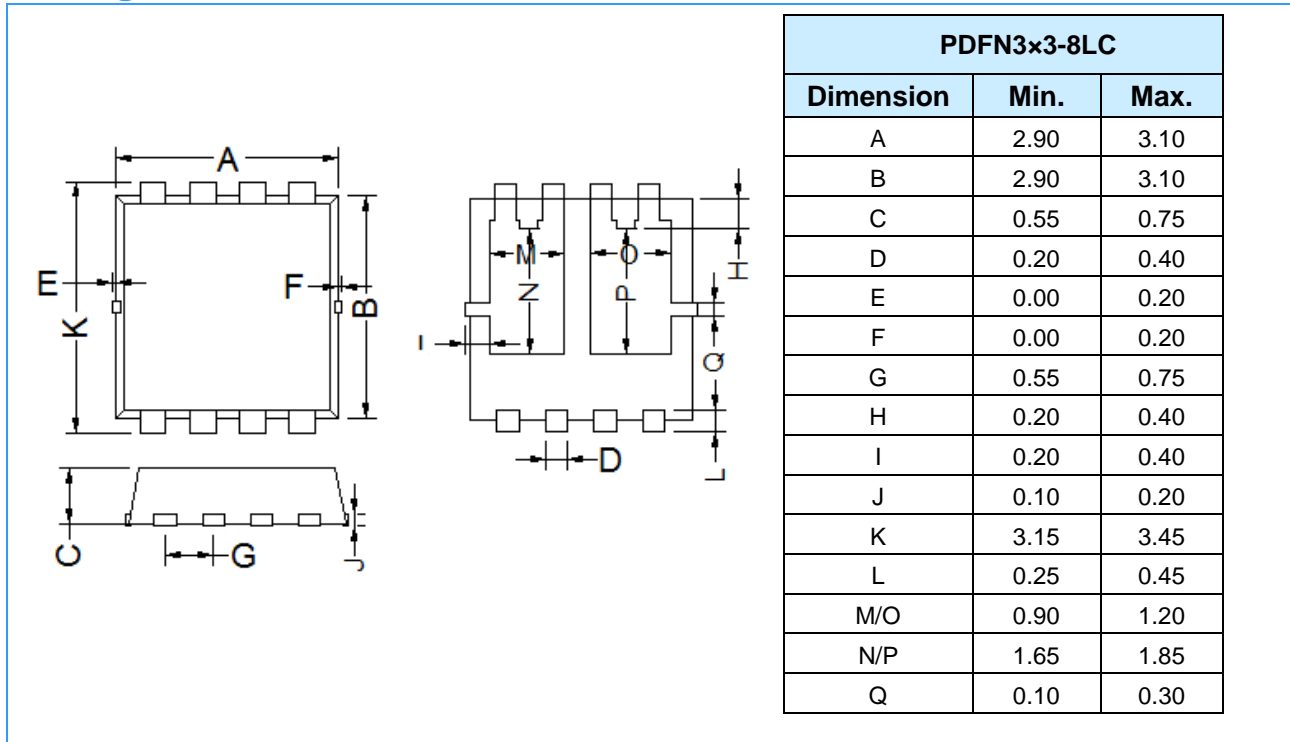
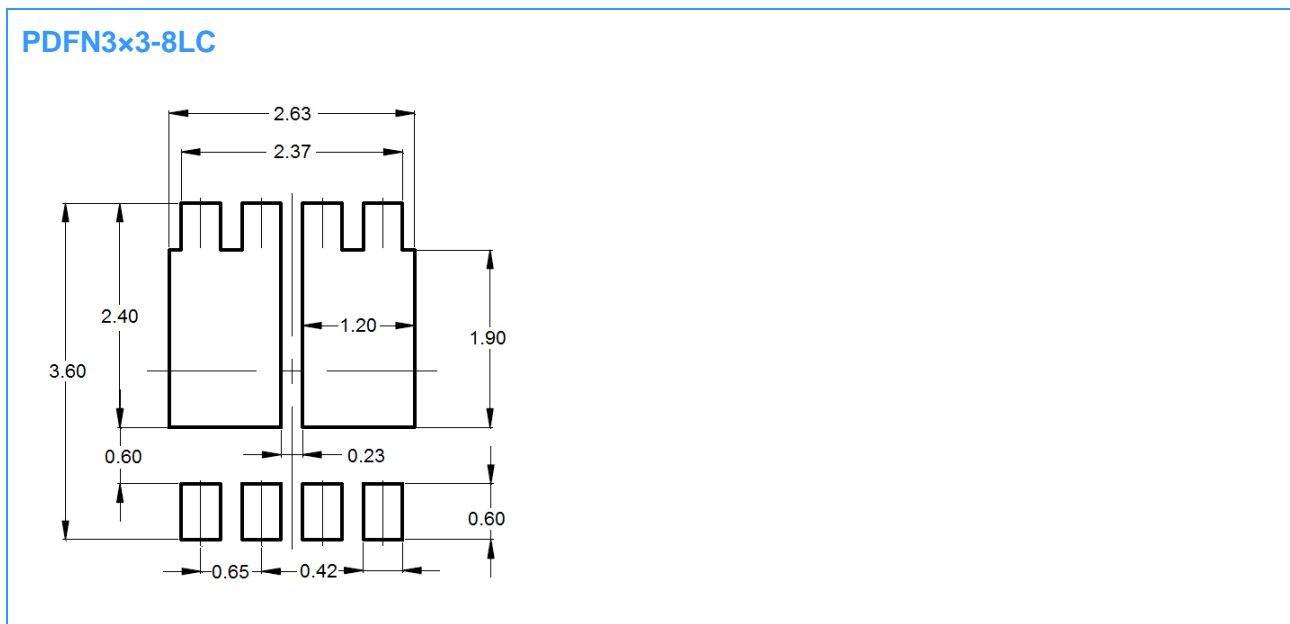


Fig 12 Normalized  $V_{GS(th)}$  vs. Junction Temperature

**Package Outline Dimensions** (Unit: mm)



**Mounting Pad Layout** (Unit: mm)



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